

# PULSER RECEIVER UTPR-CC-50



## Ultrasonic Pulser-Receiver

The UTPR-CC-50 is a computer-controlled, multi-channel ultrasonic inspection platform that can be configured as an 8 channel ultrasonic unit down to a conventional single channel pulser-receiver, and is offered as a tabletop or a rack-mountable instrument. Combining the UTPR-CC-50 with any of our TecView™ software packages would result in powerful ultrasonic inspection results

The UTPR-CC-50 is designed with applicability in mind, with specifications that can meet the most challenging demands.

### AEROSPACE...

With its reliable and powerful pulsers, pre-amplifier and receiver bandwidth adjustments, as well as the ultrasonic inspection and imaging software TecView™ UT, the UTPR-CC-50 can manage inspections of composite materials as well as aluminum or other metallic structures.

### PIPES & TUBES...

Used with the proper probes and software, the UTPR-CC-50 is the perfect tool for weld inspection with conventional, angle beam or TOFD ultrasonic scanning, as well as thickness and corrosion mapping.

### INLINE SYSTEMES...

With its multi-channel capabilities, the UTPR-CC-50 can be used to monitor and test parts on the production line from multiple angles and methodologies in a fast and efficient way.

### MORE...

The UTPR-CC-50 is a universal solution for single and multiple channel ultrasonic inspections. Whether the application requires repeatability, near & far surface resolution, penetration power or channel configuration versatility, this unit has what it takes to meet the challenge. With a receiver bandwidth adjustable from very narrow to a 50 MHz wide bandwidth and a powerful pulser that can efficiently drive high frequencies transducers, requirements of a wide range of applications can be met by the UTPR-CC-50.

[www.tecscan.ca](http://www.tecscan.ca)

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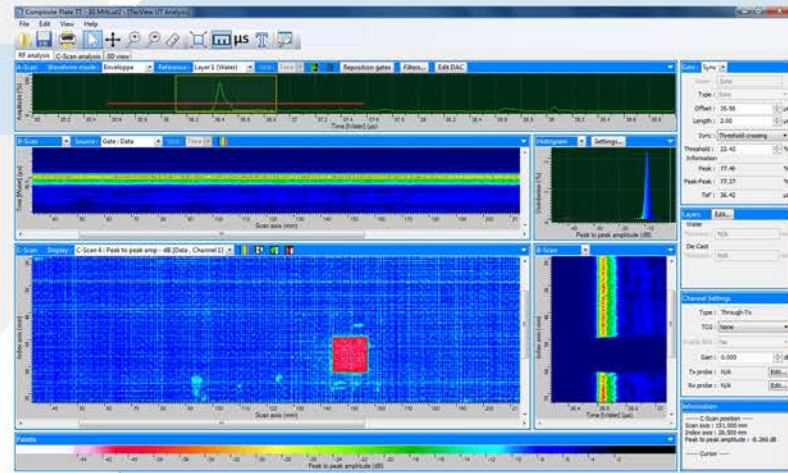
# Specifications

## CHANNELS

Number of channels  
Channels specifications  
Channels configurations

Configurable up to 8 channels  
Independent pulser and receiver on each channel  
Pulse-echo & Through-transmission

# TECVIEW™ UT



## PULSER

Pulser type  
Pulse amplitude  
Pulse width  
Damping  
Rise time  
Fall time  
PRF max  
Trigger source

Negative Spike or Square wave  
-50 to -400 V for Spike (1V steps)  
and -260V for Square (1V steps)  
Spike: Typically 10 to 100 ns  
Square: 25 to 500ns (0.1 ns steps)  
30 Ω, 33 Ω, 41 Ω, 45 Ω, 78 Ω  
97 Ω, 219 Ω, 500 Ω (None)  
< 4 ns at 260 V  
< 4 ns  
20 kHz for Spike, 5kHz for Square  
Internal/External

## RECEIVER

Gain  
Bandwidth  
High-Pass Filters  
Low-Pass Filters  
DC offset  
TT isolation  
TCG\*\*  
BEA (optional)\*\*\*

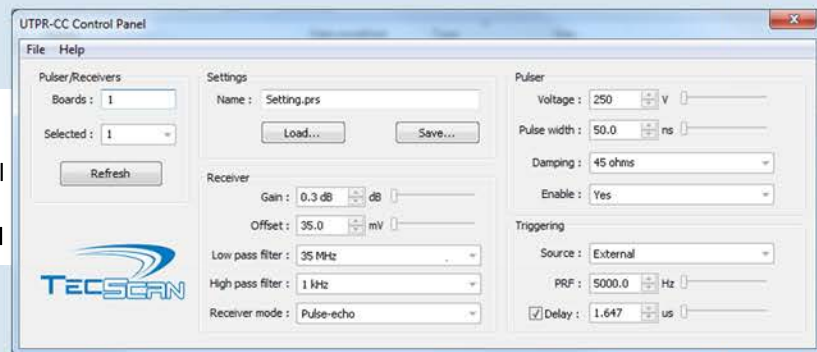
0 to 80 dB (0.1 dB steps)  
Broadband: 300 kHz – 50 MHz (-3dB)  
300 kHz (None), 500 kHz, 1 MHz, 2.5 MHz, 5 MHz, 10 MHz  
50 MHz (None), 35MHz, 25MHz, 15MHz, 10MHz, 5MHz, 2.5MHz  
-250 to 250 mV (1 mV steps)  
Typically 72 dB @ 10 MHz  
48 dB (Maximum slope of 12dB/ms, Resolution of 50ns)  
110 dB Attenuation

- INDEPENDENT PULSER & RECEIVER PER CHANNEL
- SQUARE WAVE FOR INCREASED PENETRATION
- UPTO 8 ULTRASONIC CHANNELS
- COMPUTER CONTROLLED (USB 2.0)
- BROADBAND RECEIVER
- RACKMOUNTABLE

## INPUT/OUTPUTS

Computer Interface  
Analog inputs (BNC)  
Analog outputs (BNC)  
I/O (BNC)  
Probe connection

USB 2.0  
Receiver input on each channel  
Receiver output on each channel  
Trigger input/output  
BNC connectors on each channel



## PHYSICAL PROPERTIES

Packaging  
Max Size  
Power input

Rackmount-ready box  
(H x W x D) 223mm x 432mm x 343mm (8.75" x 17" x 13.5")  
115VAC - 230VAC @ 50/60 Hz / 230 VAC @ 50 Hz

## COMBINE THE UTPR-CC-35 WITH TECVIEW™ AND GET

- Intuitive user interface
- Full waveform acquisition
- Motion control up to 12 axes
- Inspection, Imaging and Analysis modules
- Live display of A, B and C-Scans
- Inspection report generator
- Supports Phased Array Testing

- C-Scan gating capabilities (up to 16)
- Inspection of inclined surfaces
- DAC curves, TCG & BEA controls
- Defect measurement and analysis tools
- Histogram analysis
- Annotations tools
- Data export, csv, dat
- C-scans export